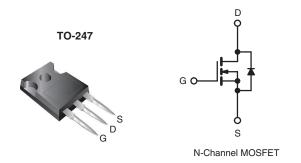


Vishay Siliconix

### **Power MOSFET**

PRODUCT SUMMARY				
V <sub>DS</sub> (V)	500			
$R_{DS(on)}\left(\Omega\right)$	V <sub>GS</sub> = 10 V	0.27		
Q <sub>g</sub> (Max.) (nC)	120			
Q <sub>gs</sub> (nC)	32			
Q <sub>gd</sub> (nC)	49			
Configuration	Single			



#### **FEATURES**

- · Ultra Low Gate Charge
- Reduced Gate Drive Requirement
- Enhanced 30 V V<sub>GS</sub> Rating
- Reduced C<sub>iss</sub>, C<sub>oss</sub>, C<sub>rss</sub>
- Isolated Central Mounting Hole
- · Dynamic dV/dt Rating
- · Repetitive Avalanche Rated
- Lead (Pb)-free Available



#### **DESCRIPTION**

This new series of low charge Power MOSFETs achieve significantly lower gate charge over conventional MOSFETs. Utilizing advanced Power MOSFETs technology the device improvements allow for reduced gate drive requirements, faster switching speeds and increased total system savings. These device improvements combined with the proven ruggedness and reliability of Power MOSFETs offer the designer a new standard in power transistors for switching applications.

The TO-247 package is preferred for commercial-industrial applications where higher power levels preclude the use of TO-220 devices. The TO-247 is similar but superior to the earlier TO-218 package because its isolated mounting hole.

ORDERING INFORMATION		
Package	TO-247	
Lead (Pb)-free	IRFP460LCPbF	
	SiHFP460LC-E3	
SnPb	IRFP460LC	
	SiHFP460LC	

PARAMETER	SYMBOL	LIMIT	UNIT		
Drain-Source Voltage		$V_{DS}$	500	V	
Gate-Source Voltage	$V_{GS}$	± 30	\ \ \		
Continuous Drain Current	$V_{GS}$ at 10 V $T_{C} = 25 ^{\circ}C$ $T_{C} = 100 ^{\circ}C$	I-	20	А	
	$T_C = 100 ^{\circ}$ C	I <sub>D</sub>	12		
Pulsed Drain Current <sup>a</sup>	I <sub>DM</sub>	80			
Linear Derating Factor			2.2	W/°C	
Single Pulse Avalanche Energy <sup>b</sup>	E <sub>AS</sub>	960	mJ		
Repetitive Avalanche Current <sup>a</sup>	I <sub>AR</sub>	20	Α		
Repetitive Avalanche Energy <sup>a</sup>	E <sub>AR</sub>	28	mJ		
Maximum Power Dissipation	T <sub>C</sub> = 25 °C	$P_{D}$	280	W	
Peak Diode Recovery dV/dtc	dV/dt	3.5	V/ns		
Operating Junction and Storage Temperature Range		T <sub>J</sub> , T <sub>stg</sub>	- 55 to + 150	°C	
Soldering Recommendations (Peak Temperature)	for 10 s		300 <sup>d</sup>	7	
Mounting Torque	6-32 or M3 screw		10	lbf ⋅ in	
	0-32 OF M3 SCIEW		1.1	N⋅m	

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. V<sub>DD</sub> = 25 V, starting T<sub>J</sub> = 25 °C, L = 4.3 mH, R<sub>G</sub> = 25  $\Omega$ , I<sub>AS</sub> = 20 A (see fig. 12). c. I<sub>SD</sub>  $\leq$  20 A, dI/dt  $\leq$  160 A/µs, V<sub>DD</sub>  $\leq$  V<sub>DS</sub>, T<sub>J</sub>  $\leq$  150 °C.
- d. 1.6 mm from case.
- \* Pb containing terminations are not RoHS compliant, exemptions may apply

# IRFP460LC, SiHFP460LC

# Vishay Siliconix



THERMAL RESISTANCE RATINGS				
PARAMETER	SYMBOL	TYP.	MAX.	UNIT
Maximum Junction-to-Ambient	R <sub>thJA</sub>	-	=	
Case-to-Sink, Flat, Greased Surface	R <sub>thCS</sub>	0.24	-	°C/W
Maximum Junction-to-Case (Drain)	R <sub>thJC</sub>	-	0.45	

<b>SPECIFICATIONS</b> $T_J = 25  ^{\circ}C$ ,	unless other	wise noted					
PARAMETER	SYMBOL	TEST CONDITIONS		MIN.	TYP.	MAX.	UNIT
Static							
Drain-Source Breakdown Voltage	V <sub>DS</sub>	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		500	-	-	V
V <sub>DS</sub> Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference t	to 25 °C, I <sub>D</sub> = 1 mA	-	0.59	-	V/°C
Gate-Source Threshold Voltage	V <sub>GS(th)</sub>	$V_{DS} = V$	$V_{DS} = V_{GS}, I_D = 250 \mu A$		-	4.0	٧
Gate-Source Leakage	I <sub>GSS</sub>	V <sub>G</sub>	V <sub>GS</sub> = ± 20 V		-	± 100	nA
Zone Ooto Walkers Busin Oursel		V <sub>DS</sub> = 500 V, V <sub>GS</sub> = 0 V		-	-	25	
Zero Gate Voltage Drain Current	I <sub>DSS</sub>	V <sub>DS</sub> = 400 V, V	/ <sub>GS</sub> = 0 V, T <sub>J</sub> = 125 °C	-	-	250	- μΑ
Drain-Source On-State Resistance	R <sub>DS(on)</sub>	V <sub>GS</sub> = 10 V	I <sub>D</sub> = 12 A <sup>b</sup>	-	-	0.27	Ω
Forward Transconductance	9 <sub>fs</sub>	V <sub>DS</sub> = 5	60 V, I <sub>D</sub> = 12 A <sup>b</sup>	12	-	-	S
Dynamic				I.	ı	•	
Input Capacitance	C <sub>iss</sub>	$V_{GS} = 0 \text{ V},$ $V_{DS} = 25 \text{ V},$ $f = 1.0 \text{ MHz, see fig. 5}$		-	3600	-	pF
Output Capacitance	C <sub>oss</sub>			-	440	-	
Reverse Transfer Capacitance	C <sub>rss</sub>			-	39	-	
Total Gate Charge	Qg		I <sub>D</sub> = 20 A, V <sub>DS</sub> = 400 V, see fig. 6 and 13 <sup>b</sup>	-	-	120	nC
Gate-Source Charge	$Q_{gs}$	V <sub>GS</sub> = 10 V		-	-	32	
Gate-Drain Charge	Q <sub>gd</sub>	1		-	-	49	
Turn-On Delay Time	t <sub>d(on)</sub>			-	18	-	
Rise Time	t <sub>r</sub>	$V_{DD} = 2$	V <sub>DD</sub> = 250 V, I <sub>D</sub> = 20 A		77	-	ns
Turn-Off Delay Time	t <sub>d(off)</sub>	$R_G = 4.3 \Omega$ , $R_D = 12 \Omega$ , see fig. $10^b$		-	40	-	
Fall Time	t <sub>f</sub>			-	43	-	
Internal Drain Inductance	L <sub>D</sub>	Between lead, 6 mm (0.25") from package and center of die contact		-	5.0	-	
Internal Source Inductance	L <sub>S</sub>			-	13	-	- nH
Drain-Source Body Diode Characteristic	s			I.			
Continuous Source-Drain Diode Current	I <sub>S</sub>	MOSFET symbol showing the integral reverse p - n junction diode		-	-	20	
Pulsed Diode Forward Current <sup>a</sup>	I <sub>SM</sub>			-	-	80	A
Body Diode Voltage	V <sub>SD</sub>	$T_J = 25 ^{\circ}\text{C}, \ I_S = 20  \text{A}, \ V_{GS} = 0  \text{V}^{\text{b}}$		-	-	1.8	V
Body Diode Reverse Recovery Time	t <sub>rr</sub>	T <sub>J</sub> = 25 °C, I <sub>F</sub> = 20 A, dl/dt = 100 A/μs <sup>b</sup>		-	570	860	ns
Body Diode Reverse Recovery Charge	Q <sub>rr</sub>			-	6.6	9.9	μC
Forward Turn-On Time	t <sub>on</sub>	Intrinsic turn-on time is negligible (turn-on is dominated by L <sub>S</sub> and L <sub>D</sub> )				L <sub>D</sub> )	

#### Notes

a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).

b. Pulse width  $\leq 300~\mu s;$  duty cycle  $\leq 2~\%.$ 



### TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

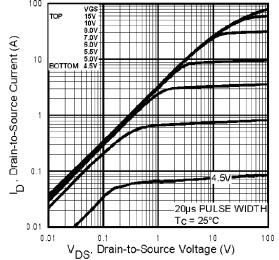


Fig. 1 - Typical Output Characteristics, T<sub>C</sub> = 25 °C

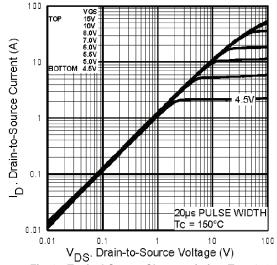


Fig. 2 - Typical Output Characteristics, T<sub>C</sub> = 150 °C

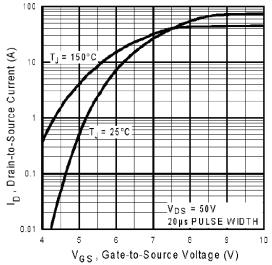


Fig. 3 - Typical Transfer Characteristics

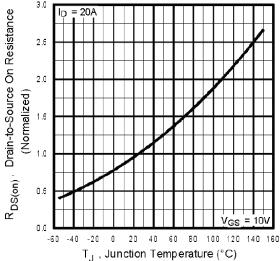


Fig. 4 - Normalized On-Resistance vs. Temperature

# IRFP460LC, SiHFP460LC

### Vishay Siliconix



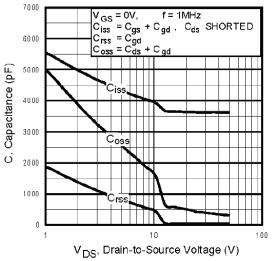


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

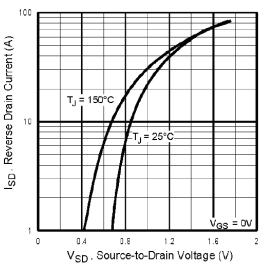


Fig. 7 - Typical Source-Drain Diode Forward Voltage

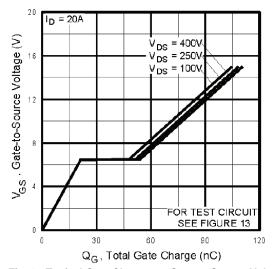


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

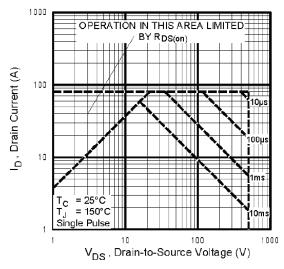


Fig. 8 - Maximum Safe Operating Area



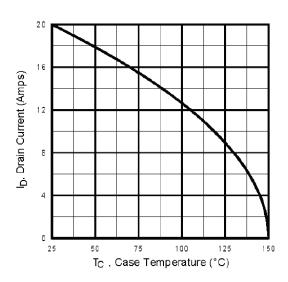


Fig. 9 - Maximum Drain Current vs. Case Temperature

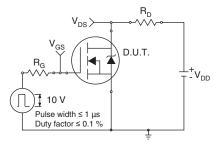


Fig. 10a - Switching Time Test Circuit

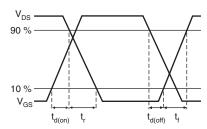


Fig. 10b - Switching Time Waveforms

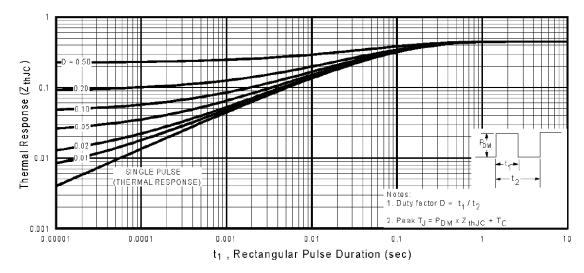


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

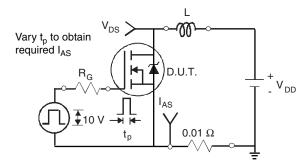


Fig. 12a - Unclamped Inductive Test Circuit

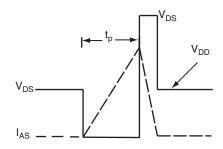


Fig. 12b - Unclamped Inductive Waveforms

# Vishay Siliconix



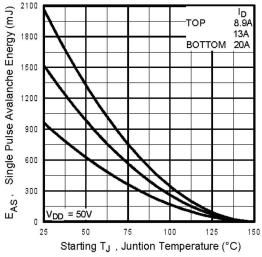


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

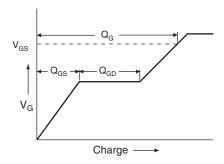


Fig. 13a - Basic Gate Charge Waveform

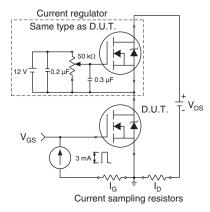
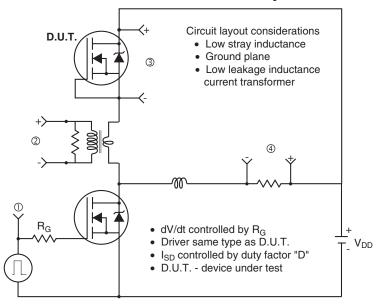
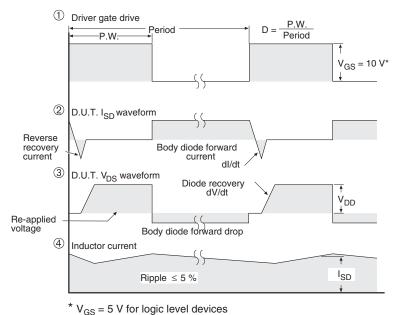


Fig. 13b - Gate Charge Test Circuit



### Peak Diode Recovery dV/dt Test Circuit





logio level devides

Fig. 14 - For N-Channel

Vishay Siliconix maintains worldwide manufacturing capability. Products may be manufactured at one of several qualified locations. Reliability data for Silicon Technology and Package Reliability represent a composite of all qualified locations. For related documents such as package/tape drawings, part marking, and reliability data, see http://www.vishay.com/ppg?91235.



Vishay

### **Disclaimer**

All product specifications and data are subject to change without notice.

Vishay Intertechnology, Inc., its affiliates, agents, and employees, and all persons acting on its or their behalf (collectively, "Vishay"), disclaim any and all liability for any errors, inaccuracies or incompleteness contained herein or in any other disclosure relating to any product.

Vishay disclaims any and all liability arising out of the use or application of any product described herein or of any information provided herein to the maximum extent permitted by law. The product specifications do not expand or otherwise modify Vishay's terms and conditions of purchase, including but not limited to the warranty expressed therein, which apply to these products.

No license, express or implied, by estoppel or otherwise, to any intellectual property rights is granted by this document or by any conduct of Vishay.

The products shown herein are not designed for use in medical, life-saving, or life-sustaining applications unless otherwise expressly indicated. Customers using or selling Vishay products not expressly indicated for use in such applications do so entirely at their own risk and agree to fully indemnify Vishay for any damages arising or resulting from such use or sale. Please contact authorized Vishay personnel to obtain written terms and conditions regarding products designed for such applications.

Product names and markings noted herein may be trademarks of their respective owners.

Revision: 18-Jul-08

Document Number: 91000 www.vishay.com